

Reliability of systems, equipment and components —

Part 13: Reliability test conditions for consumer equipment —

Section 13.4 Conditions providing a low degree of simulation for equipment for portable and non-stationary use

Committees responsible for this British Standard

The preparation of this British Standard was entrusted by the Quality, Management and Statistics Standards Policy Committee (QMS/-) to Technical Committee QMS/23, upon which the following bodies were represented:

- AEA Technology
- Association of Consulting Engineers
- Association of Project Managers
- British Gas plc
- British Railways Board
- British Telecommunications plc
- City University
- Civil Aviation Authority
- Consumers' Association
- Cranfield Institute of Technology
- Department of Trade and Industry (Standards Policy Unit Design Council)
- EEA (the Association of Electronics, Telecommunications and Business Equipment Industries)
- Electricity Association
- Electronic Components Industry Federation
- Federation of Small Businesses
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- Safety and Reliability Society
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